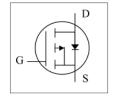


Description

The AP60P03D uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.



AP60P03D XXXX YYYY



General Features

 $V_{DS} = -30V I_{D} = -60 A$

 $R_{DS(ON)}$ < 13m Ω @ V_{GS} =10V

Application

Battery protection

Load switch

Uninterruptible power supply

Package Marking and Ordering Information

Product ID	Pack	Marking	Qty(PCS)
AP60P03D	TO-252-3L	AP60P03D XXXX YYYY	2500

Absolute Maximum Ratings (T_c=25°C unless otherwise noted)

Symbol	Parameter	Rat	Units		
V _D s	Drain-Source Voltage	-3	V		
Vgs	Gate-Source Voltage	±	V		
I _D @T _C =25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-6	-60		
I _D @T _C =100°C	Continuous Drain Current, V _{GS} @ -10V ¹	-3	-30		
I _D @T _A =25°C	Continuous Drain Current, V _{GS} @ -10V ¹	-15	-9.6	А	
I _D @T _A =70°C	Continuous Drain Current, V _{GS} @ -10V ¹	-12 -7.7		А	
Ірм	Pulsed Drain Current ² -150				
EAS	Single Pulse Avalanche Energy ³	125		mJ	
las	Avalanche Current	-50		А	
P _D @T _C =25°C	Total Power Dissipation ⁴	4	45		
P _D @T _A =25°C	Total Power Dissipation ⁴	5	2.0	W	
Тѕтс	Storage Temperature Range -55 to 150		°C		
TJ	Operating Junction Temperature Range -55 to 150		150	°C	
Reja	Thermal Resistance Junction-Ambient ¹ 62		52	°C/W	
R ₀ JA	Thermal Resistance Junction-Ambient ¹ (t ≤10s)	25		°C/W	
Rejc	Thermal Resistance Junction-Case ¹	2.8		°C/W	



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-30			V	
∆BVbss/∆TJ	BVDSS Temperature Coefficient Reference to 25°C , I _D =-1mA			-0.0232		V/°C	
Rds(on)	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-30A		9.6	13	mΩ	
		V _{GS} =-4.5V , I _D =-15A		13	18		
VGS(th)	Gate Threshold Voltage		-1.0		-2.5	V	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =-250uA		4.6		mV/°C	
IDSS	Drain-Source Leakage Current	V _{DS} =-24V , V _{GS} =0V , T _J =25°C			-1	uA	
1055		V_{DS} =-24V , V_{GS} =0V , T_{J} =55 $^{\circ}$ C			-5	- uA	
Igss	Gate-Source Leakage Current	V_{GS} = $\pm 25V$, V_{DS} = $0V$			±100	nA	
gfs	Forward Transconductance	V _{DS} =-5V , I _D =-30A		30		S	
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		9		Ω	
Qg	Total Gate Charge (-4.5V)			22			
Qgs	Gate-Source Charge	ge V _{DS} =-15V , V _{GS} =-4.5V , I _D =-		8.7		nC	
Qgd	Gate-Drain Charge			7.2			
Td(on)	Turn-On Delay Time			8			
Tr	Rise Time	V_{DD} =-15V , V_{GS} =-10V ,		73.7			
Td(off)	Turn-Off Delay Time R _G =3.3 I _D =-15A			61.8		ns	
T _f	Fall Time			24.4		1	
Ciss	Input Capacitance			2215			
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		310		pF	
Crss	Reverse Transfer Capacitance			237			
ls	Continuous Source Current ^{1,5}				-45	Α	
lsм	Pulsed Source Current ^{2,5}	V _G =V _D =0V , Force Current			-150	Α	
VsD	Diode Forward Voltage ²	V _{GS} =0V , I _S =-1A , T _J =25°C			-1	V	
trr	Reverse Recovery Time	IF=-15A , dI/dt=100A/μs ,		19		nS	
Qrr	Reverse Recovery Charge	T _J =25°C		9		nC	

Note:

^{1.} The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

^{2.}The data tested by pulsed , pulse width $\leq 300 us$, duty cycle $\leq 2\%$

^{3.} The EAS data shows Max. rating . The test condition is V_{DD} =-25V, V_{GS} =-10V, L=0.1mH, I_{AS} =-50A

^{4.}The power dissipation is limited by 150°C junction temperature 5.The data is theoretically the same as lo and low, in real applications, should be limited by total power dissipation.



Typical Characteristics

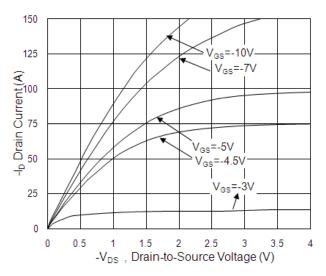


Fig.1 Typical Output Characteristics

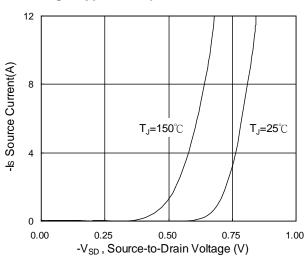


Fig.3 Forward Characteristics of Reverse

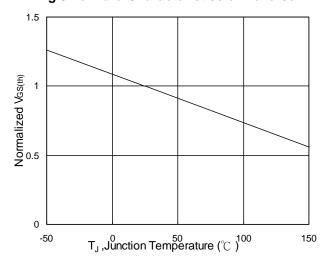


Fig.5 Normalized V_{GS(th)} vs. T_J

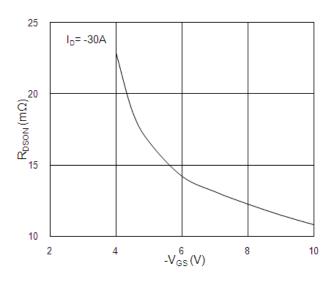


Fig.2 On-Resistance vs. G-S Voltage

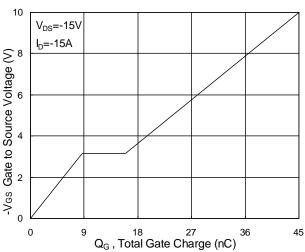


Fig.4 Gate-charge Characteristics

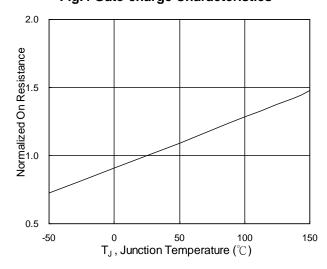
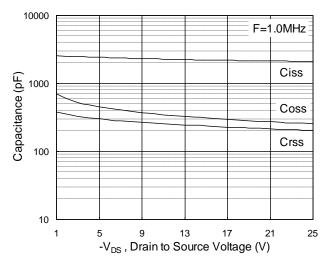


Fig.6 Normalized R_{DSON} vs. T_J







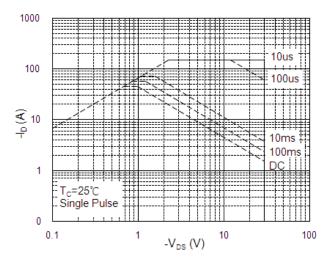


Fig.7 Capacitance

Fig.8 Safe Operating Area

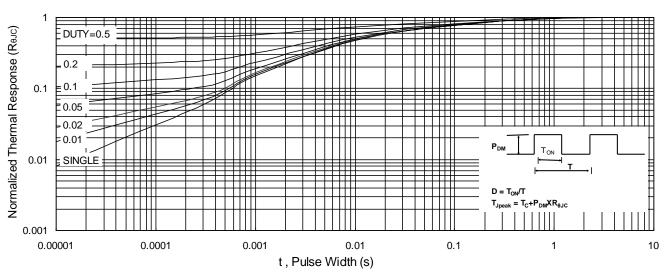
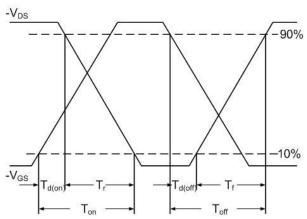


Fig.9 Normalized Maximum Transient Thermal Impedance





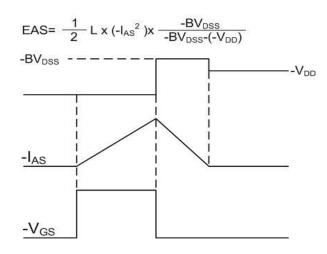
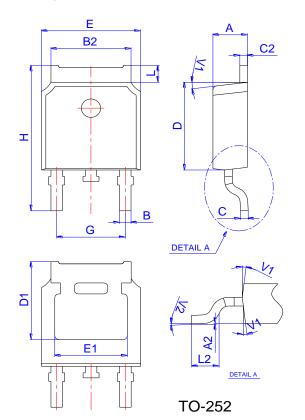


Fig.11 Unclamped Inductive Switching Waveform

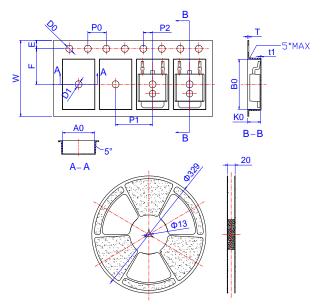


Package Mechanical Data



	Dimensions					
Ref.	Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.
Α	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
В	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
С	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
Н	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°

Reel Spectification-TO-252



	Dimensions					
Ref.	Millimeters			Inches		
	Min.	Тур.	Max.	Min.	Тур.	Max.
W	15.90	16.00	16.10	0.626	0.630	0.634
E	1.65	1.75	1.85	0.065	0.069	0.073
F	7.40	7.50	7.60	0.291	0.295	0.299
D0	1.40	1.50	1.60	0.055	0.059	0.063
D1	1.40	1.50	1.60	0.055	0.059	0.063
P0	3.90	4.00	4.10	0.154	0.157	0.161
P1	7.90	8.00	8.10	0.311	0.315	0.319
P2	1.90	2.00	2.10	0.075	0.079	0.083
A0	6.85	6.90	7.00	0.270	0.271	0.276
В0	10.45	10.50	10.60	0.411	0.413	0.417
K0	2.68	2.78	2.88	0.105	0.109	0.113
Т	0.24		0.27	0.009		0.011
t1	0.10			0.004		
10P0	39.80	40.00	40.20	1.567	1.575	1.583



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